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Main Switch Power MOSFET and Single Charging BJT

–12 V, –6.2 A, Single P–Channel FET with Single PNP low V_{ce(sat)} Transistor, 3x3 mm WDFN Package

This device integrates one high performance power MOSFET and one low $V_{ce(sat)}$ transistor, greatly reducing the layout space and optimizing charging performance in battery-powered portable electronics.

Features

- High Performance Power MOSFET
- Single Low V_{ce(sat)} Transistor as Charging Power Mux
- 3.0x3.0x0.8 mm WDFN Package
- Independent Pin-out Provides Circuit Flexibility
- Low Profile (<0.8 mm) for Easy Fit in Thin Environments
- This is a Pb–Free Device

Applications

- Main Switch and Battery Charging Mux for Portable Electronics
- Optimized for Commercial PMUs from Top Suppliers (See Figure 2)

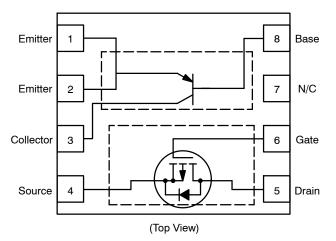


Figure 1. Simple Schematic



ON Semiconductor®

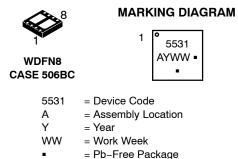
http://onsemi.com

MOSFET

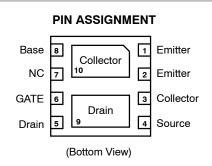
V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX
-12 V	32 mΩ @ –4.5 V	-6.2 A
-12 V	44 mΩ @ −2.5 V	-0.2 A

Low V_{ce(sat)} PNP (Wall/USB)

V _{CEO} MAX	V _{EBO} MAX	I _C MAX
–20 V	–7.0 V	–2.0 A



(Note: Microdot may be in either location)



ORDERING INFORMATION

Device	Package	Shipping †
NUS5531MTR2G	WDFN8 (Pb-Free)	3000/Tape & Reel

+ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

P-Channel Power MOSFET Maximum Ratings (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Units
Drain-to-Source Voltage			V _{DSS}	-12	V
Gate-to-Source Voltage			V _{GS}	±8.0	V
Continuous Drain Current (Note 1)	Steady State	$T_A = 25^{\circ}C$	I _D	-5.47	A
		T _A = 85°C		-4.0	
	t ≤ 5 s	T _A = 25°C		-6.2	
Power Dissipation (Note 1)	Steady State	T 0500	PD	1.46	W
	t ≤ 10 s	T _A = 25°C		2.1	
Continuous Drain Current (Note 2)	Steady State	T _A = 25°C	I _D	-4.4	А
		T _A = 85°C		-3.2	
Power Dissipation (Note 3)	T _A =	25°C	PD	0.418	W
Pulsed Drain Current	t _p = 1	10 μs	I _{DM}	-25	А
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to 150	°C
Operating Case Temperature (Note 3)			T _C	-55 to 125	°C
Source Current (Body Diode) ²			ا _S	-2.8	А
Lead Temperature for Soldering Purposes (1/8" from o	case for 10 s)		TL	260	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	299	°C/W
Junction-to-Ambient - t < 10 s (Note 3)	$R_{\theta JA}$	81.4	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	85.5	°C/W
Junction-to-Ambient - t < 10 s (Note 1)	$R_{\theta JA}$	58.7	°C/W
Junction-to-Case - t < 10 s (Note 3)	ΨЈС	26	°C/W

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 sq in [1 oz] including traces).

2. Surface-mounted on FR4 board using 0.5 in sq pad size, 1 oz. Cu.

3. Surface-mounted on FR4 board using 50 sq mm pad size, 1 oz. Cu.

P-Channel MOSFET Electrical Characteristics (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						

Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = –250 μ A		-12.0			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	$I_D = -250 \ \mu\text{A}$, ref to 25°C			-10.1		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			-1.0	μΑ
		V _{DS} = -12 V	T _J = 125°C			-10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, '	V _{GS} = ±8 V			±200	nA

ON CHARACTERISTICS (Note 4)

Gate Threshold Voltage	V _{GS(TH)}	V_{GS} = V_{DS} , I_D = -250 μ A	-0.45	-0.67	-1.1	V
Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$			2.68		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V_{GS} = -4.5 V, I _D = -3.0 A		32	40	mΩ
		V_{GS} = -2.5 V, I _D = -3.0 A		44	50	
Forward Transconductance	9 FS	V_{DS} = -16 V, I _D = -3.0 A		5.9		S

4. Pulsed Condition: Pulse Width = 300 $\mu sec, \, Duty \, Cycle \leq 2\%$

P-Channel MOSFET Electri	cal Characteristics (T _J = 25°C unless	s otherwise specified)
--------------------------	---------------------------------------------------	------------------------

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
CHARGES, CAPACITANCES AND GAT	E RESISTANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f	= 1.0 MHz,		1329		pF
Output Capacitance	C _{OSS}	V _{DS} =	V _{DS} = -12 V		200		
Reverse Transfer Capacitance	C _{RSS}				116		
Total Gate Charge	Q _{G(tot)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -12 \text{ V},$ $I_{D} = -3.0 \text{ A}$			13		nC
Threshold Gate Charge	Q _{G(th)}	I _D = -	-3.0 A		1.1		
Gate-to-Source Charge	Q _{GS}	-			1.7		
Gate-to-Drain Charge	Q _{GD}				2.5		1
SWITCHING CHARACTERISTICS							
Turn-On Delay Time	t _{d(on)}	$V_{GS} = -4.5 V,$	V _{DD} = -12 V, A, R _G = 3.0		8		ns
Rise Time	tr	$I_{\rm D} = -3.0 F$	A, R _G = 3.0		17.5		
Turn-Off Delay Time	t _{d(off)}				80		
Fall Time	t _f	1			56.5		
DRAIN-SOURCE DIODE CHARACTER	RISTICS						
Forward Recovery Voltage	V _{SD}	$V_{GS} = 0 V$, $T_J = 25^{\circ}C$			-0.66	-1.2	V
		I _S = -1.0 A	T _J = 125°C		-0.54		1
Reverse Recovery Time	t _{rr}	V _{GS} :			70.8		ns
Charge Time	t _a	dISD/dt = I _S = -	100 A/μs, 1.0 A		14.3		1
		-			1		

Single–PNP Transistor Maximum Ratings (T_J = $25^{\circ}C$ unless otherwise stated)

t_b

 $\mathsf{Q}_{\mathsf{R}\mathsf{R}}$

Discharge Time

Reverse Recovery Charge

Parameter	Symbol	Value	Units
Collector-Emitter Voltage	V _{CEO}	-20	V
Collector-Base Voltage	V _{CBO}	-20	V
Emitter-Base Voltage	V _{EBO}	-7.0	V
Collector Current, Continuous	Ι _C	-2.0	Α
Collector Current, Peak	Ι _C	-4.0	А
Operating Junction and Storage Temperature	T _J , T _{STG}	–55 to 150	°C
Power Dissipation, $T_A = 25^{\circ}C$ (Note 5)	PD	1.58	W
Thermal Resistance (Note 5)	R_{\thetaJA}	61.5	°C/W
Power Dissipation, $T_A = 25^{\circ}C$ (Note 6)	PD	0.43	W
Thermal Resistance (Note 6)	R_{\thetaJA}	293	°C/W

56.4

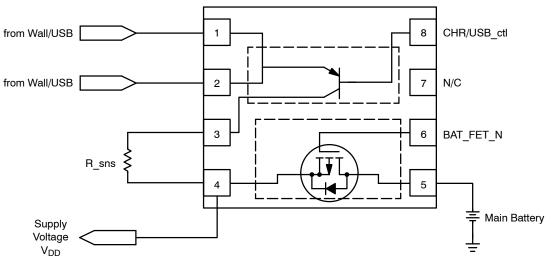
44

nC

Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 sq in [1 oz] including traces)
 Surface-mounted on FR4 board using 50 sq mm pad size, 1 oz. Cu.

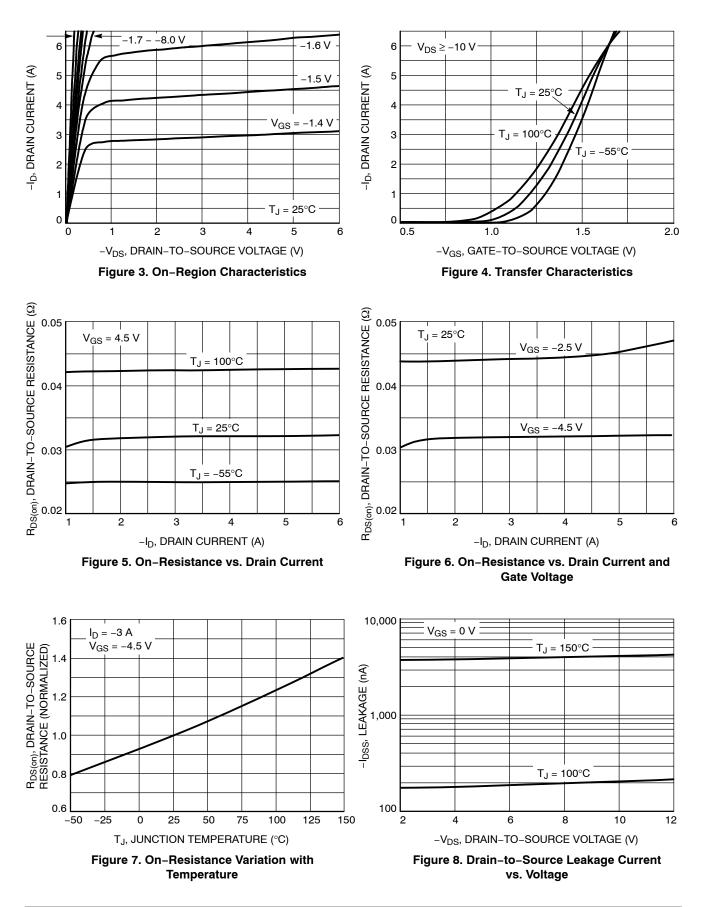
Parameter	Symbol	Test Condition	Min	Тур	Max	Units
OFF CHARACTERISTICS			-	•	•	
Collector-Emitter Breakdown Voltage	Vbr _{CEO}	$I_{\rm C} = -10$ mA, $I_{\rm B} = 0$	-20			V
Collector-Base Breakdown Voltage	Vbr _{CBO}	$I_{\rm C} = -0.1 \text{ mA}, I_{\rm E} = 0$	-20			V
Emitter-Base Breakdown Voltage	Vbr _{EBO}	$I_{\rm E} = -0.1 {\rm mA}, I_{\rm C} = 0$	-7.0			V
Collector-Emitter Cutoff Current	I _{CES}	V _{CES} = -15 V			-0.1	μA
ON CHARACTERISTICS						
DC Current Gain (Note 7)	h _{FE}	$I_{\rm C}$ = -1.0 A, $V_{\rm CE}$ = -2.0 V	180			-
DC Current Gain (Note 7)	h _{FE}	I_{C} = -2.0 A, V_{CE} = -2.0 V	150			-
Collector-Emitter Saturation Voltage	V _{CE(sat)}	$I_{\rm C} = -1.0$ A, $I_{\rm B} = -0.01$ A		-0.10	-0.12	V
Collector-Emitter Saturation Voltage	V _{CE(sat)}	$I_{\rm C} = -1.0$ A, $I_{\rm B} = -0.1$ A		-0.065	-0.09	V
Collector-Emitter Saturation Voltage	V _{CE(sat)}	$I_{\rm C}$ = -2.0 A, $I_{\rm B}$ = -0.2 A		-0.13	-0.18	V
Base-Emitter Saturation Voltage (Note 7)	V _{BE(sat)}	I _C = -1.0 A, I _B = -0.01 A			-0.9	V
Base-Emitter Turn-On Voltage (Note 7)	V _{BE(on)}	$I_{\rm C}$ = -1.0 A, $I_{\rm B}$ = -2.0 A			-0.9	V
Cutoff Frequency (Note 8)	f _T	$I_{C} = -100 \text{ mA}, V_{CE} = -5.0 \text{ V}$ f = 100 MHz	100			MHz
Input Capacitance (Note 8)	C _{ibo}	V _{EB} = -0.5 V, f = 1.0 MHz			330	pF
Output Capacitance (Note 8)	C _{obo}	V _{CB} = -3.0 V, f = 1.0 MHz			100	pF

7. Pulsed Condition: Pulse Width = 300 $\mu sec,$ Duty Cycle $\leq 2\%$ 8. Guaranteed by design but not tested.

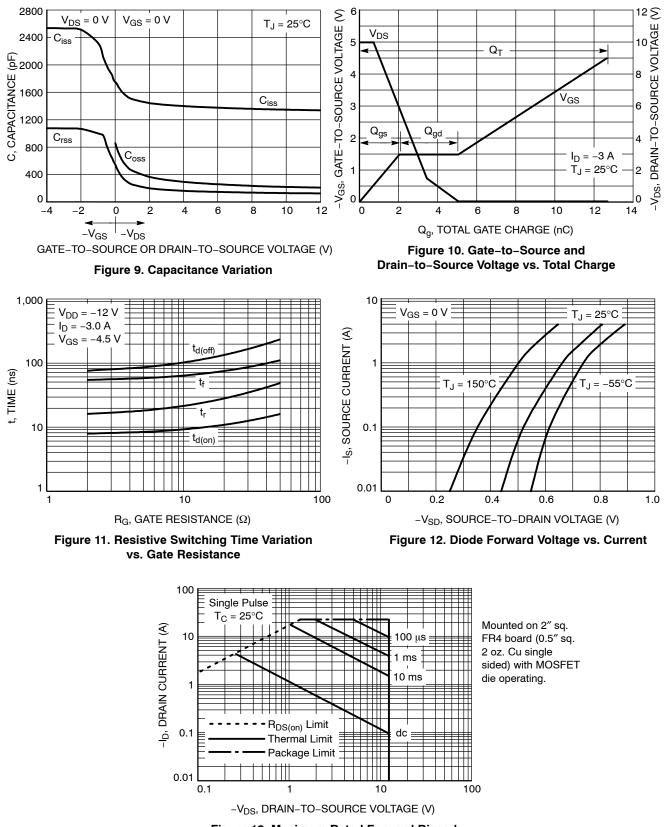




TYPICAL CHARACTERISTICS – MOSFET



TYPICAL CHARACTERISTICS – MOSFET





TYPICAL CHARACTERISTICS – MOSFET

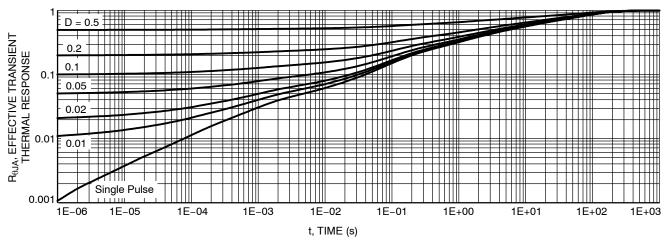
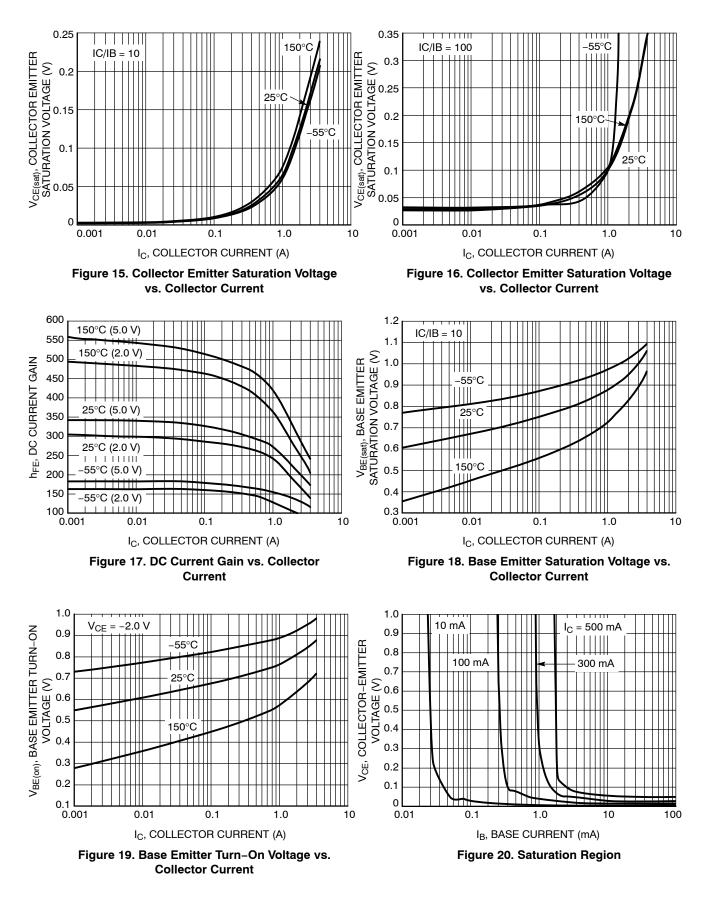
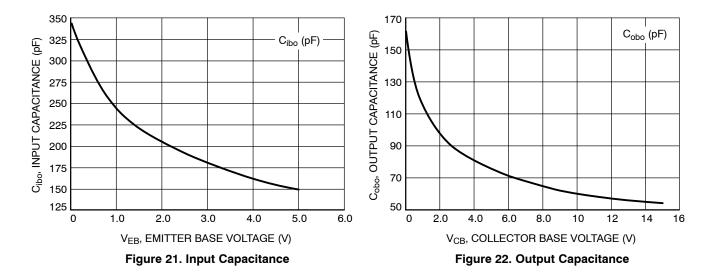


Figure 14. FET Thermal Response

TYPICAL CHARACTERISTICS – BJT

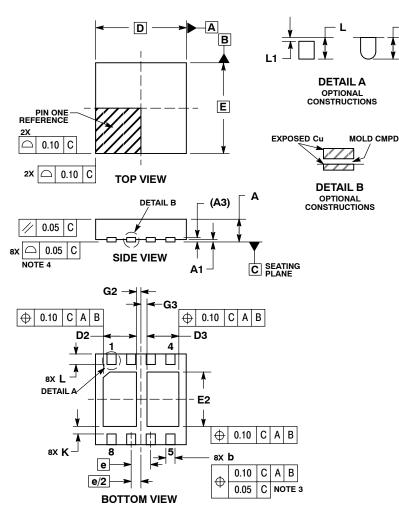


TYPICAL CHARACTERISTICS – BJT



PACKAGE DIMENSIONS

WDFN8, 3x3, 0.65P CASE 506BC-01 ISSUE A

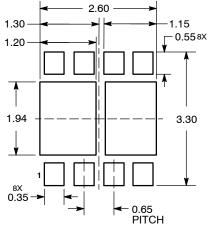


NOTES: 1. DIMENSIONING AND TOLERANCING PER

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
- CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS				
DIM	MIN	MAX			
Α	0.70	0.80			
A1	0.00	0.05			
A3	0.20 REF				
b	0.25	0.35			
D	3.00 BSC				
D2	1.00	1.20			
D3	0.95	1.15			
Е	3.00 BSC				
E2	1.70	1.90			
е	0.65 BSC				
G2	0.15 BSC				
G3	0.20 BSC				
К	0.20				
L	0.25	0.45			
L1		0.15			

SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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